



US00D827008S

(12) **United States Design Patent** (10) **Patent No.:** **US D827,008 S**
Okada et al. (45) **Date of Patent:** **** Aug. 28, 2018**

(54) **MICROSCOPE**
(71) Applicant: **Sysmex Corporation**, Kobe-shi, Hyogo (JP)
(72) Inventors: **Masaya Okada**, Kobe (JP); **Fumie Shibata**, Kobe (JP); **Shigeki Iwanaga**, Kobe (JP); **Masayuki Seki**, Kobe (JP)
(73) Assignee: **SYSMEX CORPORATION**, Hyogo (JP)
(**) Term: **15 Years**

D663,338 S * 7/2012 Okamoto D16/131
8,279,374 B2 10/2012 Park et al.
D715,843 S * 10/2014 Kawai D16/131
D719,991 S * 12/2014 Ko D15/199
D741,314 S * 10/2015 Kwak D14/253
D782,466 S * 3/2017 Yopez D14/307
D785,690 S * 5/2017 Klein D16/131
(Continued)

FOREIGN PATENT DOCUMENTS

CN 201730076159 * 3/2017
JP 2011-085888 A 4/2011
(Continued)

(21) Appl. No.: **29/596,818**
(22) Filed: **Mar. 10, 2017**
(30) **Foreign Application Priority Data**
Sep. 12, 2016 (JP) 2016-019676
(51) **LOC (11) Cl.** **16-06**
(52) **U.S. Cl.**
USPC **D16/131**
(58) **Field of Classification Search**
USPC D16/130, 131, 134, 136, 137, 219, 235,
D16/237; D26/120, 124; D14/126, 307,
D14/335, 336, 340, 371, 448
CPC G02B 21/004; G02B 21/008; G02B
21/0088; G02B 21/20; G02B 21/22;
G02B 21/24
See application file for complete search history.

OTHER PUBLICATIONS

Sysmex Super-Resolution Fluorescence Microscope Wins Good Design Gold Award 2017. Online, published date: Nov. 2, 2017. Retrieved on Feb. 26, 2018 from URL: <http://www.sysmex.co.jp/en/corporate/news/2017/171102.html>.*

Primary Examiner — Garth Rademaker
Assistant Examiner — Omeed Agilee
(74) *Attorney, Agent, or Firm* — Brinks Gilson & Lione

(57) **CLAIM**

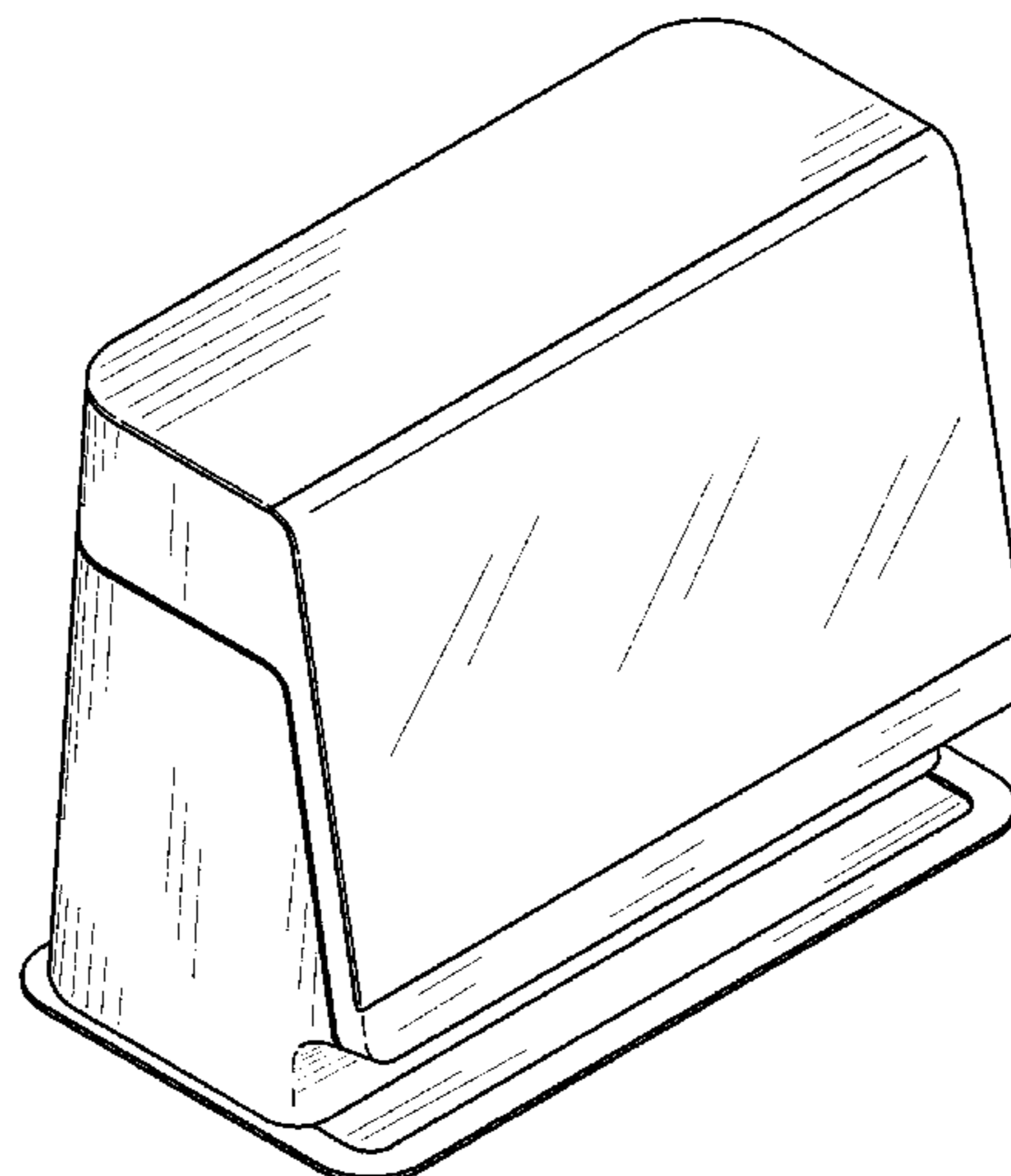
We claim the ornamental design for a microscope, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of a microscope of the present invention;
FIG. 2 is a front view thereof;
FIG. 3 is a rear view thereof;
FIG. 4 is a right side view thereof;
FIG. 5 is a left side view thereof;
FIG. 6 is a top plan view thereof; and,
FIG. 7 is a bottom plan view thereof.
The broken lines in the drawings depict portions of the microscope that form no part of the claimed design.

1 Claim, 7 Drawing Sheets

(56) **References Cited**
U.S. PATENT DOCUMENTS
D381,857 S * 8/1997 Swaim D7/307
D577,053 S * 9/2008 Watanabe D16/239
D584,306 S * 1/2009 Maiers D14/356
D587,707 S * 3/2009 Maiers D14/356
D600,726 S * 9/2009 Claassen D15/199
D602,935 S * 10/2009 Kettula D14/371
D656,978 S * 4/2012 Stoiakine D16/131



(56)

References Cited

U.S. PATENT DOCUMENTS

D794,816 S * 8/2017 Koyama D24/224
D806,698 S * 1/2018 Thompson D14/307

FOREIGN PATENT DOCUMENTS

JP 2015-084060 A 4/2015
JP 2016-164540 A 9/2016

* cited by examiner

Fig. 1

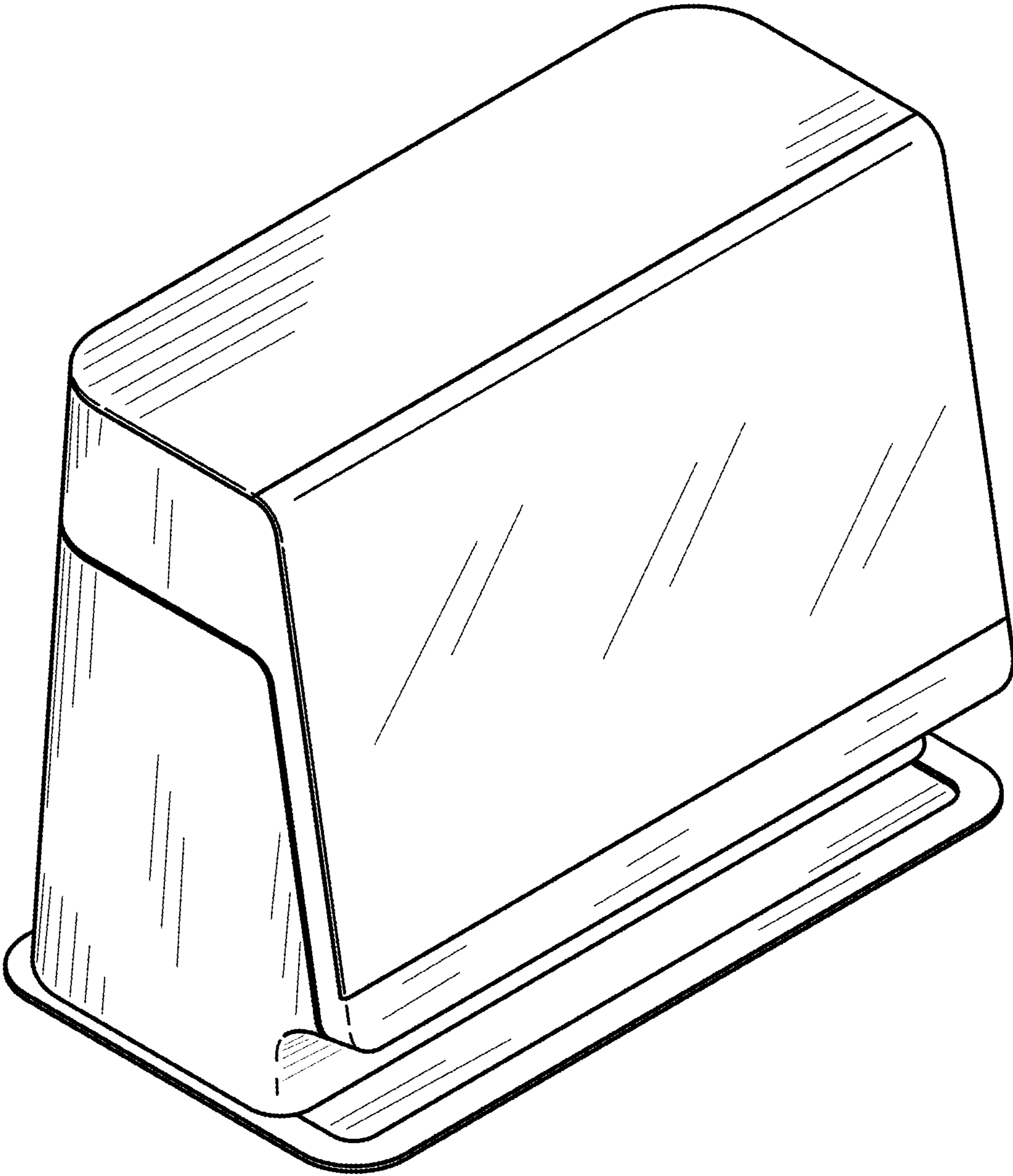


Fig. 2

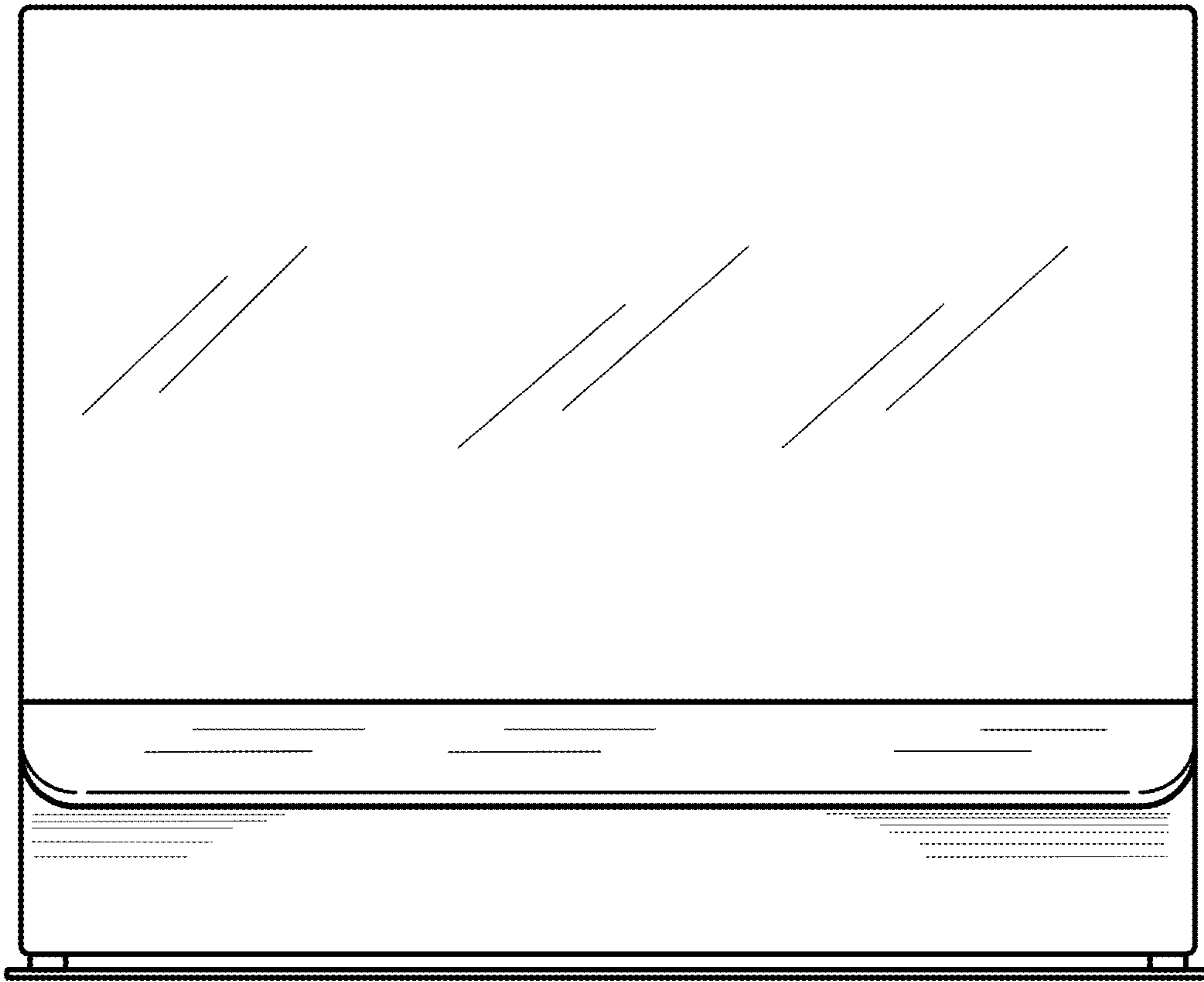


Fig. 3

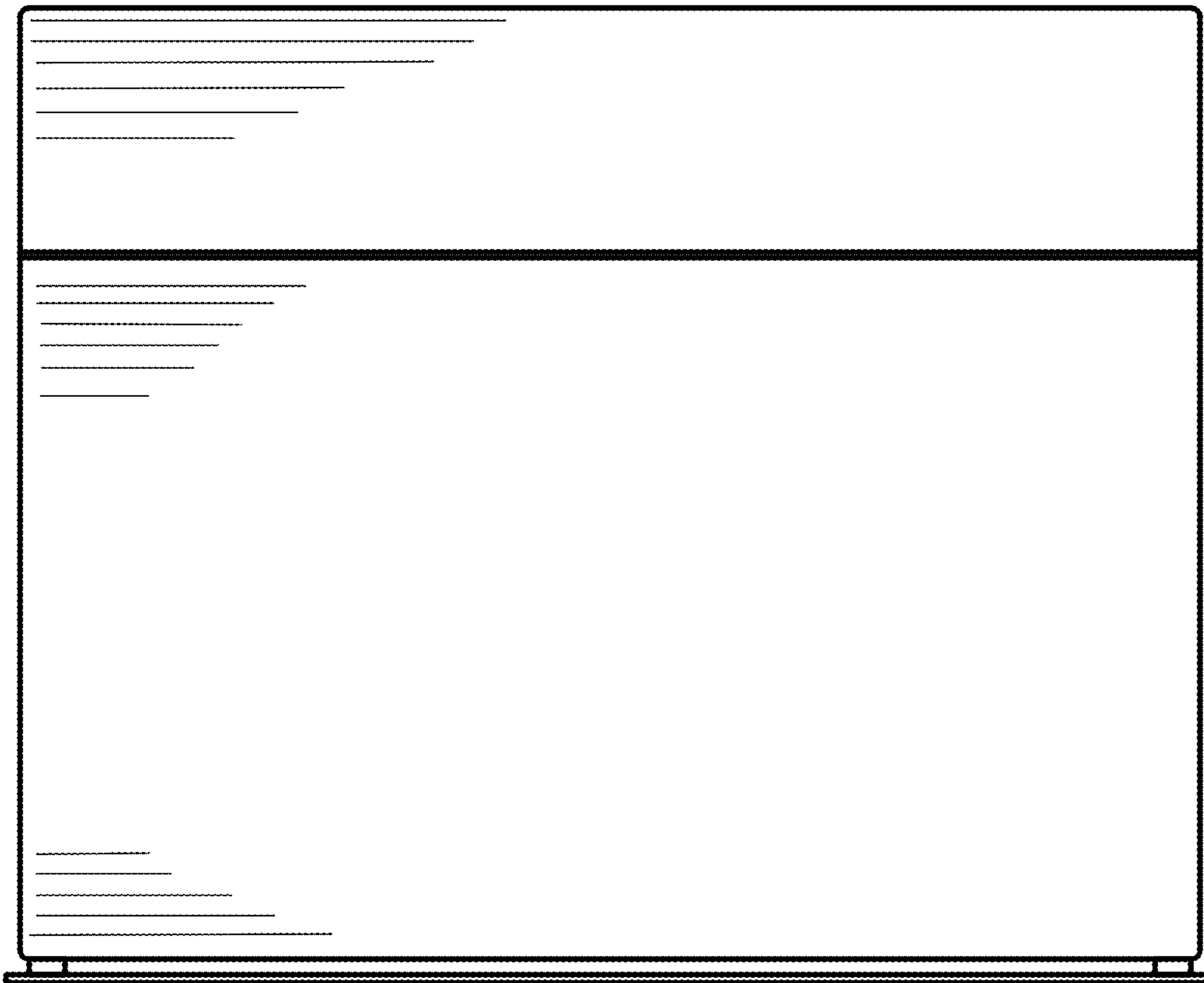


Fig. 4

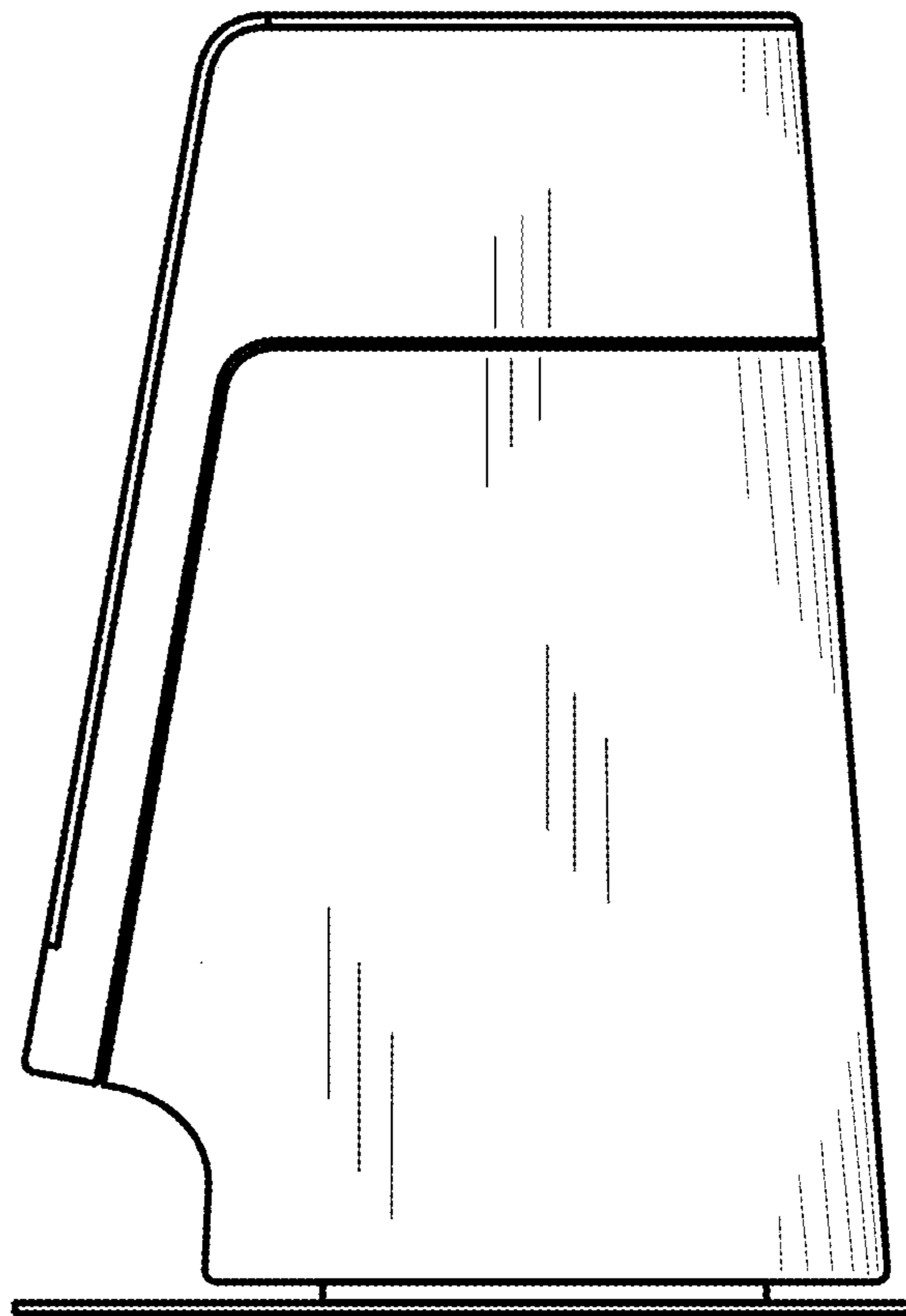


Fig. 5

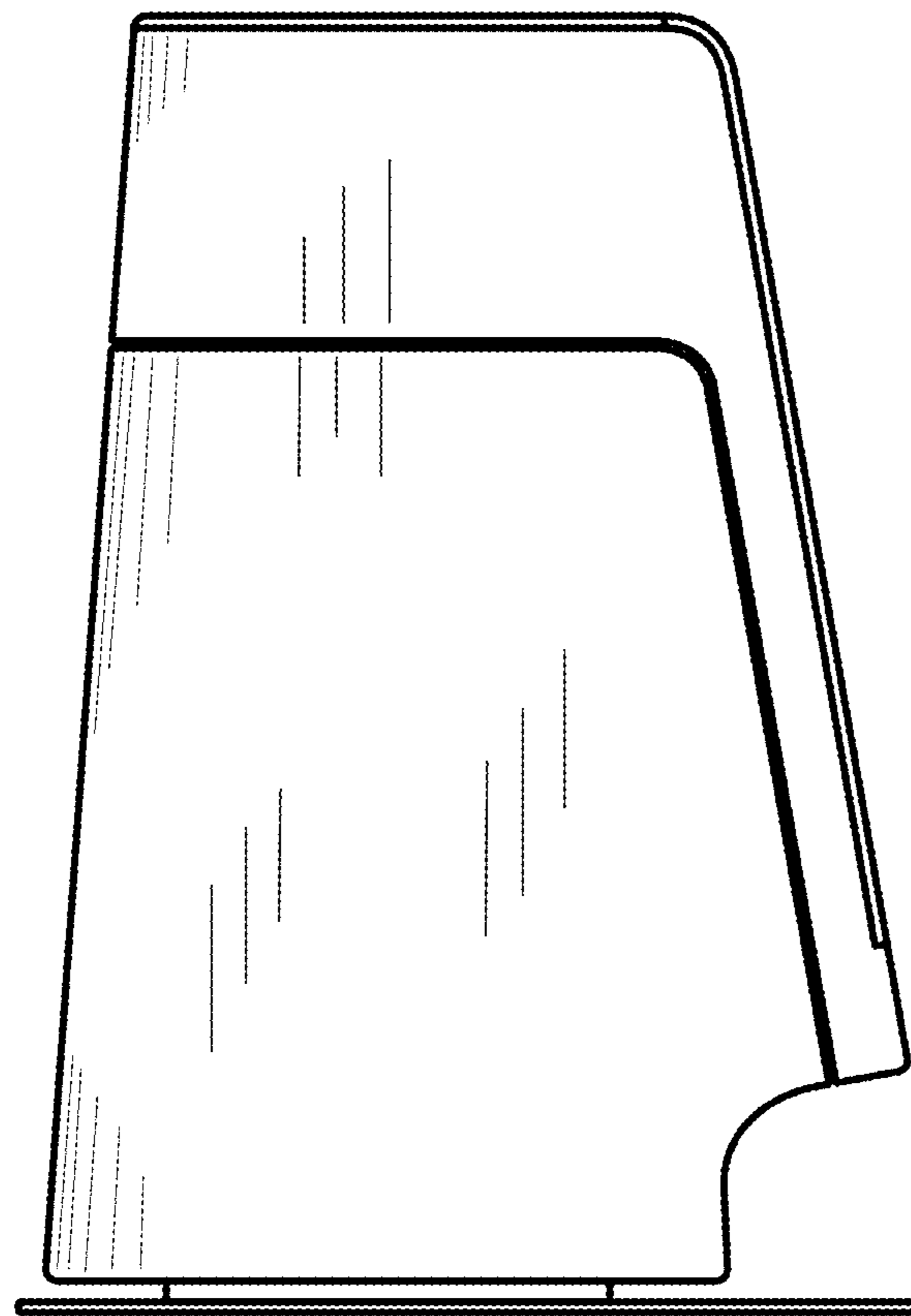


Fig. 6

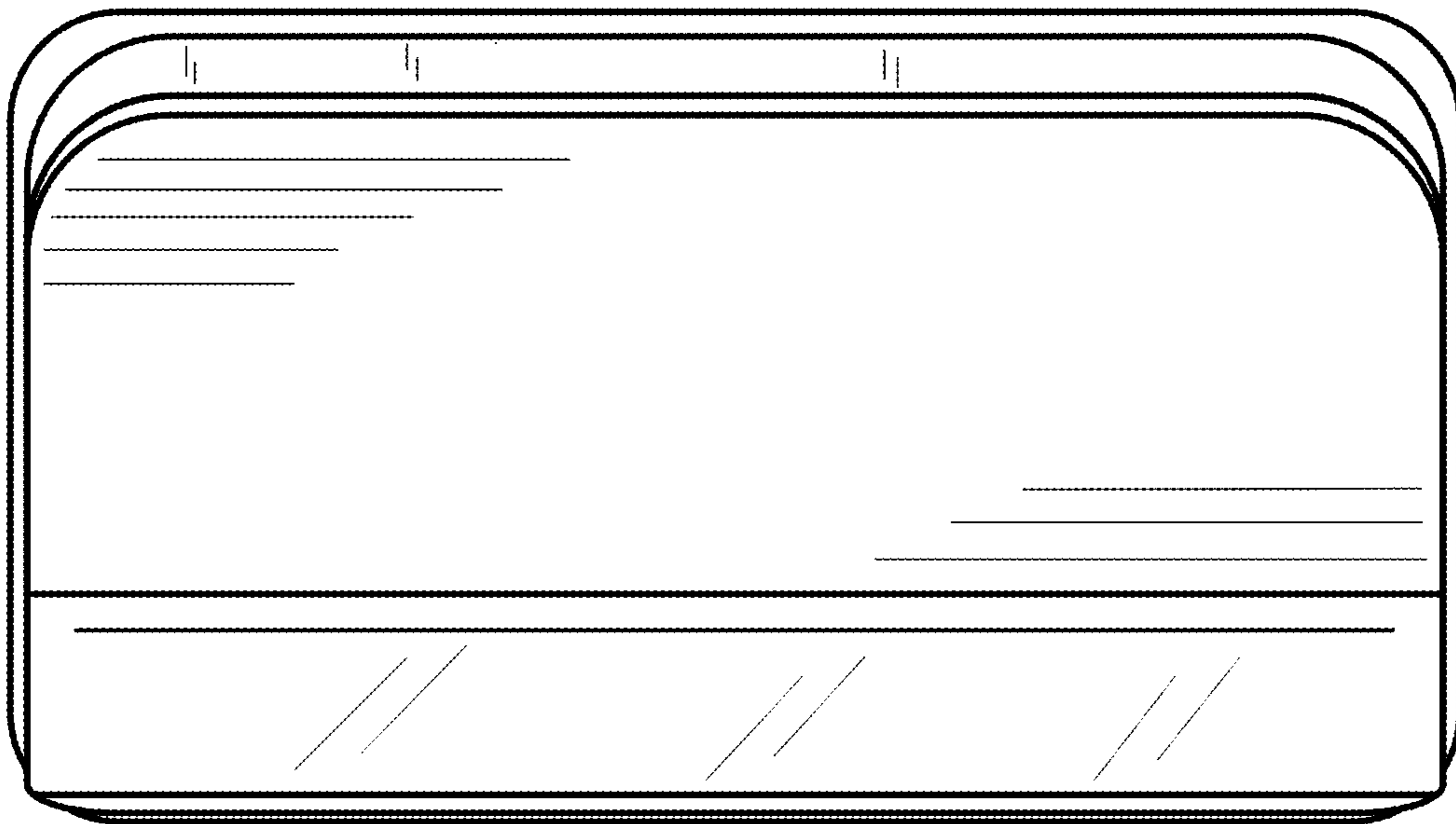


Fig. 7

